

1. General description

WG15N120HFW1 uses advanced Fine Trench Field-stop IGBT technology with anti-parallel diode in TO247 package. This device is part of the High speed series of IGBTs, which represents an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converter.



2. Features and benefits

- Maximum junction temperature 175°C
- High switching speed
- Positive Temperature efficient for Easy Parallel Operating
- Very soft, fast recovery anti-parallel diode
- EMI Improved Design

3. Applications

- Solar inverter
- UPS
- Welding converters
- PFC
- Mid to high switching frequency applications

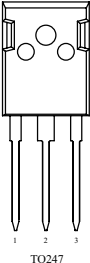
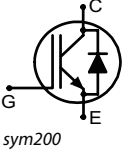
4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Notes	Value			Unit	
V _{CE}	Collector-emitter voltage, T _j ≥ 25 °C		1200			V	
I _C	DC collector current, limited by T _{j(max)} T _C = 100 °C		15			A	
Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
V _{CE(sat)}	Collector-emitter saturation voltage	V _{GE} = 15 V; I _C = 15 A; T _j = 15 °C		-	1.65	2.15	V

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	C	collector		
3	E	emitter		
mb	C	mounting base; connected to collector		

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WG15N120HFW1	TO247	WG15N120HFW1Q	Tube	30	TO247P	09-Mar-2023

7. Marking

Table 4. Marking codes

Type number	Marking codes
WG15N120HFW1	G15N120 HFW1

8. Limiting values

Table 5. Limiting values

Symbol	Parameter	Notes	Value	Unit
V_{CE}	Collector-emitter voltage, $T_j \geq 25\text{ }^{\circ}\text{C}$		1200	V
I_C	DC collector current, limited by $T_{j(max)}$ $T_C = 25\text{ }^{\circ}\text{C}$ $T_C = 100\text{ }^{\circ}\text{C}$		30 15	A
$I_{C(puls)}$	Pulsed collector current, t_p limited by $T_{j(max)}$		45	A
-	Turn off safe operating area $V_{CE} \leq 1200\text{ V}$, $T_j \leq 175\text{ }^{\circ}\text{C}$, $t_p = 1\text{ }\mu\text{s}$		45	A
I_F	Diode forward current, limited by $T_{j(max)}$ $T_C = 25\text{ }^{\circ}\text{C}$ $T_C = 100\text{ }^{\circ}\text{C}$		30 15	A
I_{Fpuls}	Diode pulsed current, t_p limited by $T_{j(max)}$		45	A
V_{GE}	Gate-emitter voltage		± 20	V
P_{tot}	Power dissipation $T_C = 25\text{ }^{\circ}\text{C}$ Power dissipation $T_C = 100\text{ }^{\circ}\text{C}$		79 39	W
T_{stg}	Storage temperature		-55 to +150	$^{\circ}\text{C}$
T_{jmax}	Maximum operating junction temperature		175	$^{\circ}\text{C}$
-	Peak soldering temperature		260	$^{\circ}\text{C}$
M	Mounting Torque with washer		0.55	Nm

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-c)}$	IGBT thermal resistance from junction to case			-	1.9	-	K/W
$R_{th(j-c)}$	Diode thermal resistance from junction to case			-	2.0	-	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient			-	40	-	K/W

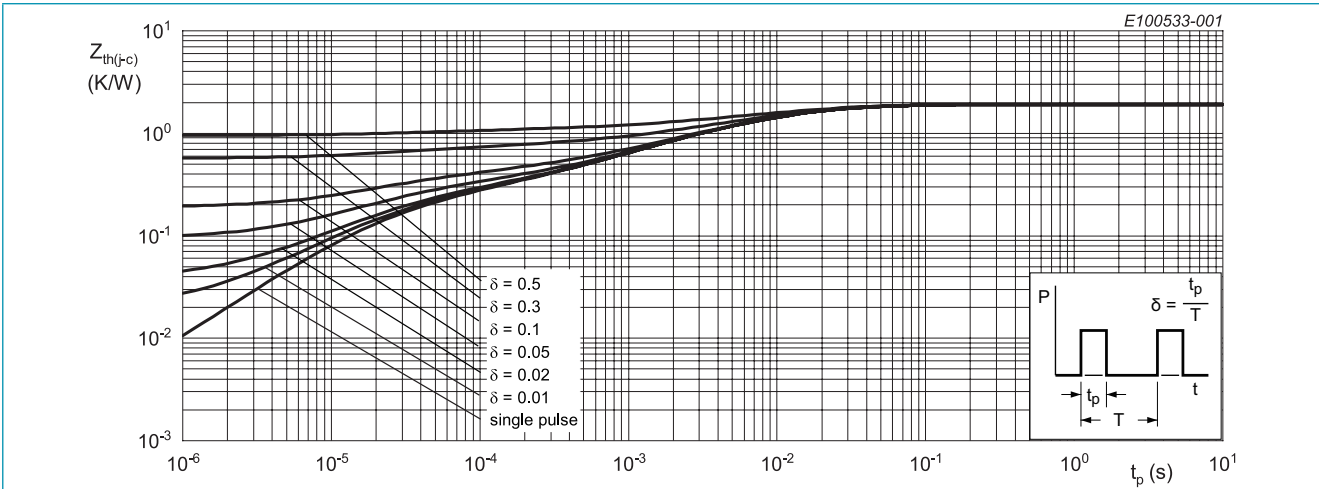


Fig. 1. Transient thermal impedance from junction to case as a function of pulse duration; IGBT

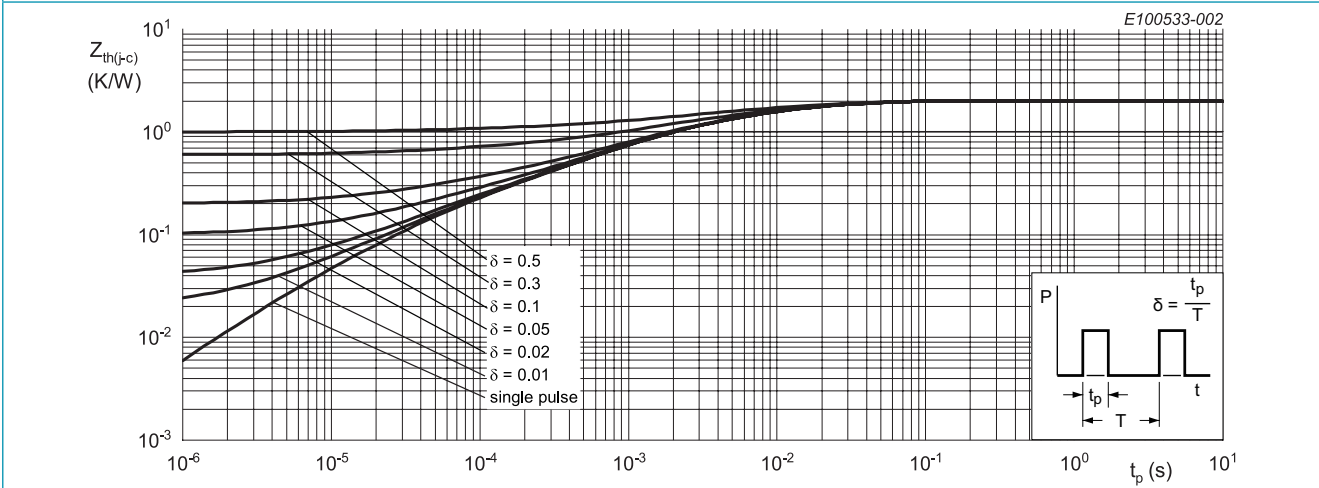


Fig. 2. Transient thermal impedance from junction to case as a function of pulse duration; Diode

10. Characteristics

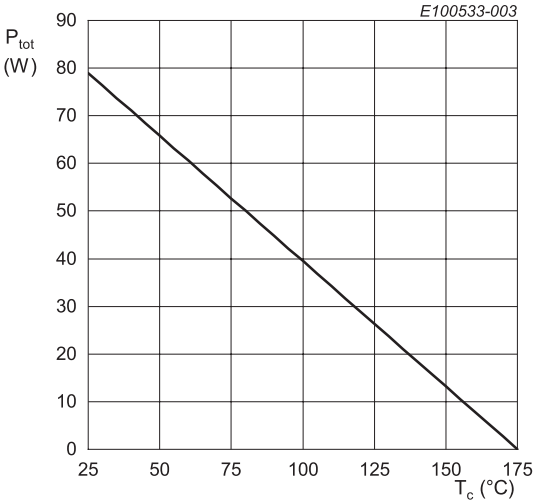
Table 7. Characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
Static characteristics							
BV_{CES}	Collector-emitter breakdown voltage	$V_{GE} = 0\text{ V}; I_C = 1\text{ mA}$		1200	-	-	V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}; I_C = 15\text{ A}; T_j = 25\text{ °C}$		-	1.65	2.15	V
		$V_{GE} = 15\text{ V}; I_C = 15\text{ A}; T_j = 175\text{ °C}$		-	2.15	-	V
V_F	Diode forward voltage	$V_{GE} = 0\text{ V}; I_F = 15\text{ A}; T_j = 25\text{ °C}$		-	2.45	-	V
		$V_{GE} = 0\text{ V}; I_F = 15\text{ A}; T_j = 175\text{ °C}$		-	2.25	-	V
$V_{GE(th)}$	Gate-emitter threshold voltage	$I_C = 150\text{ }\mu\text{A}; V_{CE} = V_{GE}$		4.1	5.2	6.3	V
I_{CES}	Zero gate voltage collector current	$V_{CE} = 1200\text{ V}; V_{GE} = 0\text{ V}; T_j = 25\text{ °C}$		-	-	250	μA
		$V_{CE} = 1200\text{ V}; V_{GE} = 0\text{ V}; T_j = 175\text{ °C}$		-	-	2.5	mA
g_{fs}	Transconductance	$V_{CE} = 20\text{ V}; I_C = 15\text{ A}$		-	25	-	S
Dynamic characteristics							
C_{ies}	Input capacitance	$V_{CE} = 30\text{ V}; V_{GE} = 0\text{ V}; f = 1\text{ MHz}; T_j = 25\text{ °C}$		-	2330	-	pF
C_{oes}	Output capacitance			-	40	-	pF
C_{res}	Reverse transfer capacitance			-	20	-	pF
Q_G	Gate charge	$V_{CC} = 960\text{ V}; I_C = 15\text{ A}; V_{GE} = 15\text{ V}; T_j = 25\text{ °C}$		-	108	-	nC

11. Switching Characteristics

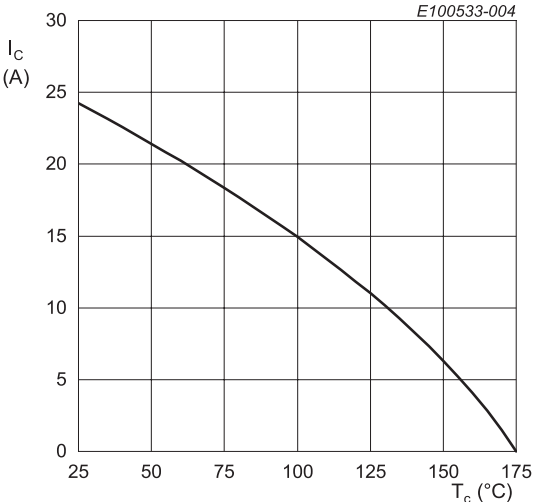
Table 8. Switching Characteristics, Inductive Load

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
IGBT characteristics							
t _{d(on)}	Turn-on delay time	T _J = 25 °C; V _{CC} = 600 V; I _C = 15 A; V _{GE} = 15V /0V; R _G = 10 Ω		-	30	-	nS
t _r	Rise time			-	14	-	nS
t _{d(off)}	Turn-off delay time			-	185	-	nS
t _f	Fall time			-	58	-	nS
E _{on}	Turn-on energy			-	0.6	-	mJ
E _{off}	Turn-off energy			-	0.45	-	mJ
E _{ts}	Total switching energy			-	1.05	-	mJ
t _{d(on)}	Turn-on delay time	T _J = 175 °C; V _{CC} = 600 V; I _C = 15 A; V _{GE} = 15V /0V; R _G = 10 Ω		-	28	-	nS
t _r	Rise time			-	15	-	nS
t _{d(off)}	Turn-off delay time			-	230	-	nS
t _f	Fall time			-	121	-	nS
E _{on}	Turn-on energy			-	0.9	-	mJ
E _{off}	Turn-off energy			-	0.7	-	mJ
E _{ts}	Total switching energy			-	1.6	-	mJ
Diode characteristics							
t _{rr}	Reverse recovery time	T _J = 25 °C; V _R = 600 V; I _F = 15 A; dI _F /dt = 800A/us		-	70	-	nS
Q _r	Reverse recovery charge			-	670	-	nC
I _{RM}	Reverse recovery peak current			-	19	-	A
t _{rr}	Reverse recovery time	T _J = 175 °C; V _R = 600 V; I _F = 15 A; dI _F /dt = 800A/us		-	98	-	nS
Q _r	Reverse recovery charge			-	1304	-	nC
I _{RM}	Reverse recovery peak current			-	25	-	A



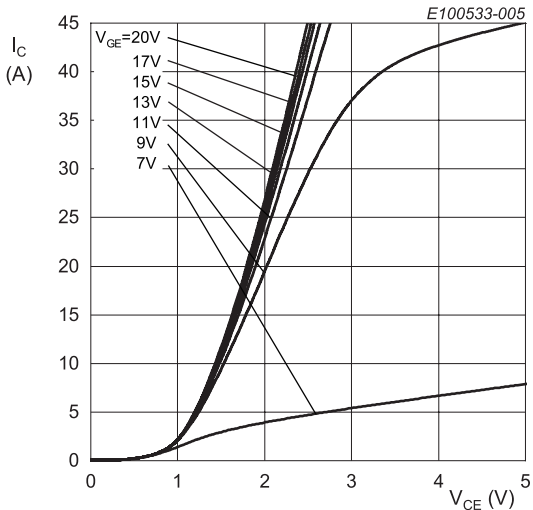
$T_j \leq 175\text{ }^{\circ}C$

Fig. 3. Power dissipation as a function of case temperature



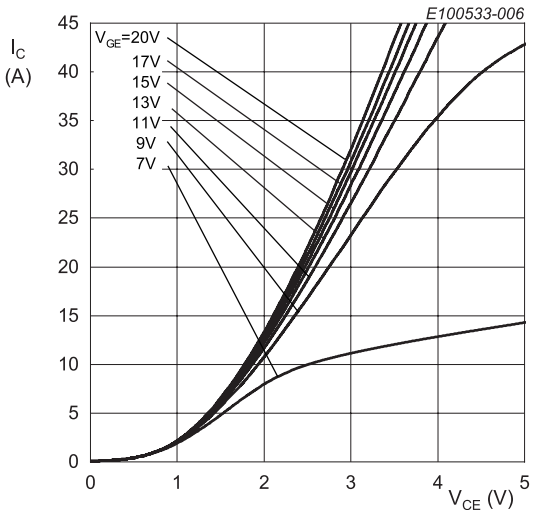
$V_{GE} \geq 15\text{ V}; T_j \leq 175\text{ }^{\circ}C$

Fig. 4. Collector current as a function of case temperature



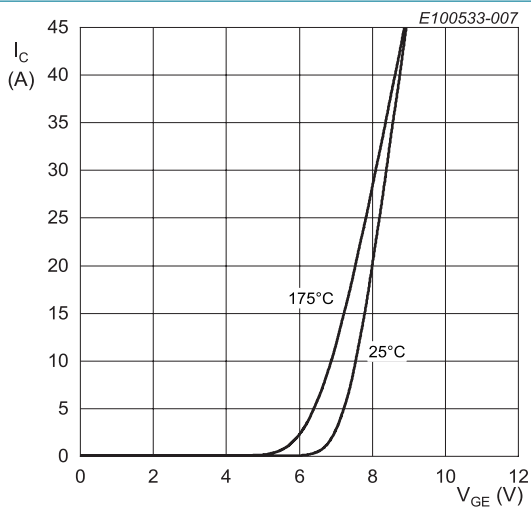
$T_j = 25\text{ }^{\circ}C$

Fig. 5. Typical output characteristic



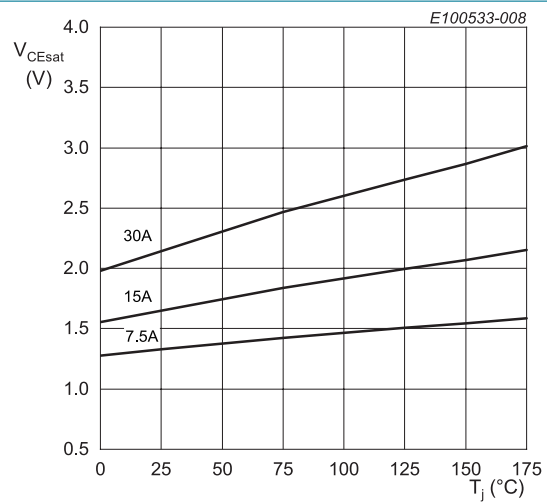
$T_j = 175\text{ }^{\circ}C$

Fig. 6. Typical output characteristic



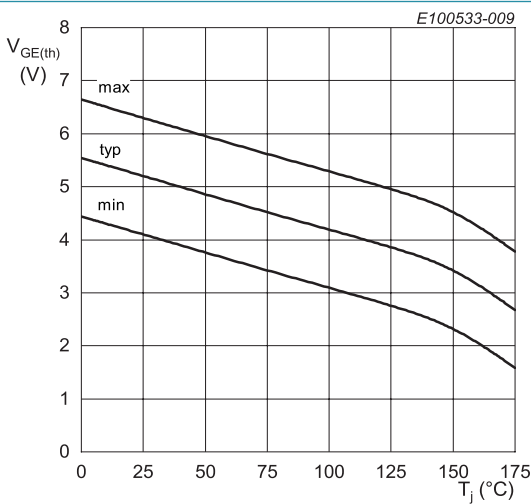
$V_{CE} = 20\text{ V}$

Fig. 7. Typical transfer characteristic



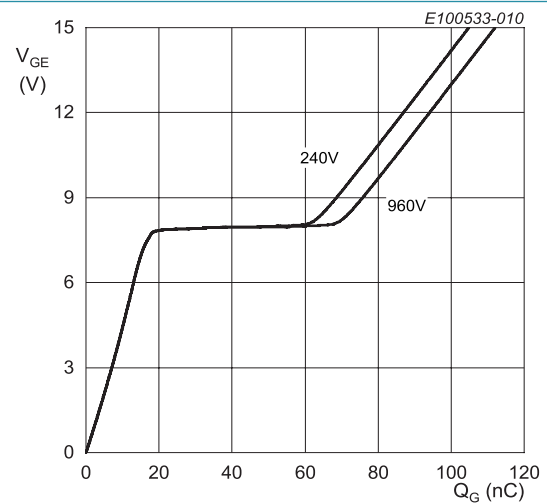
$V_{GE} = 15\text{ V}$

Fig. 8. Typical collector-emitter saturation voltage as a function of junction temperature



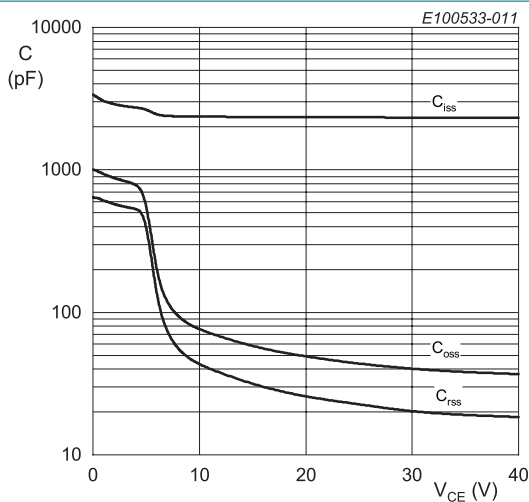
$I_C = 150\text{ }\mu\text{A}$

Fig. 9. Gate-emitter threshold voltage as a function of junction temperature



$I_C = 15\text{ A}$

Fig. 10. Typical gate charge



$V_{GE} = 0\text{ V}; f = 1\text{ MHz}$
Fig. 11. Typical capacitance as a function of collector-emitter voltage

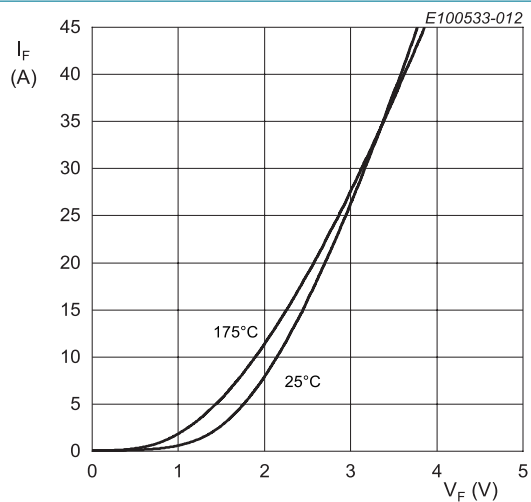
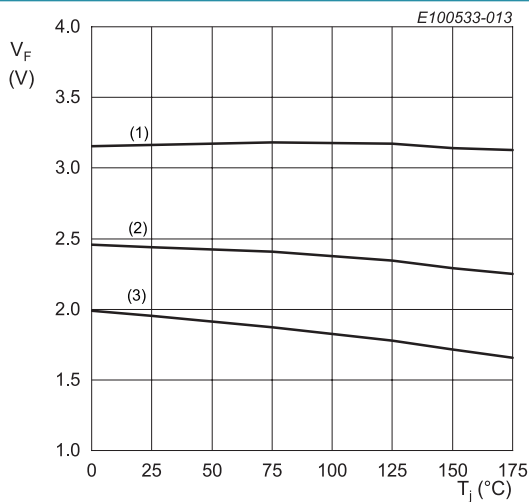
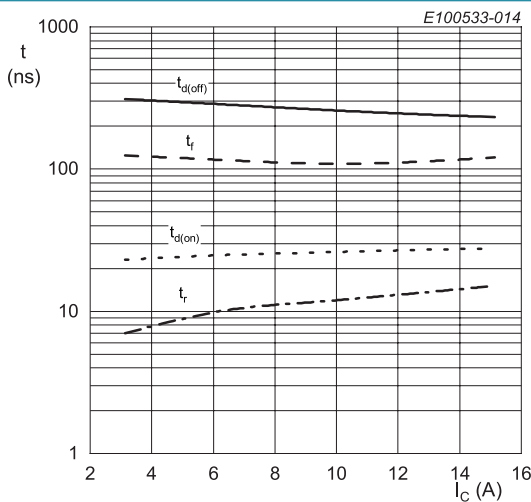


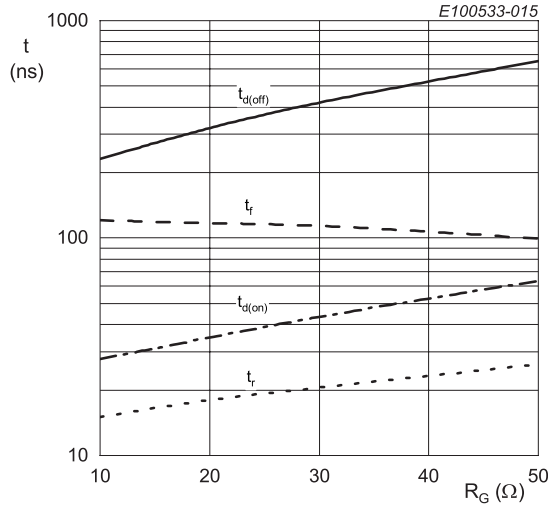
Fig. 12. Typical diode forward current as a function of forward voltage



(1) $I_F = 30\text{ A}$
(2) $I_F = 15\text{ A}$
(3) $I_F = 7.5\text{ A}$
Fig. 13. Typical diode forward voltage as a function of junction temperature

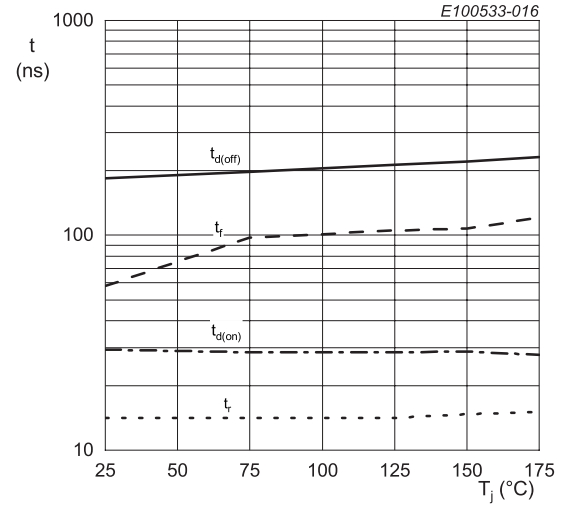


$R_g = 10\text{ }\Omega; V_{GE} = 15\text{ V}/0\text{ V}; T_j = 175\text{ }^\circ\text{C};$
 $V_{CE} = 600\text{ V};$ inductive load
Fig. 14. Typical switching times as a function of collector current



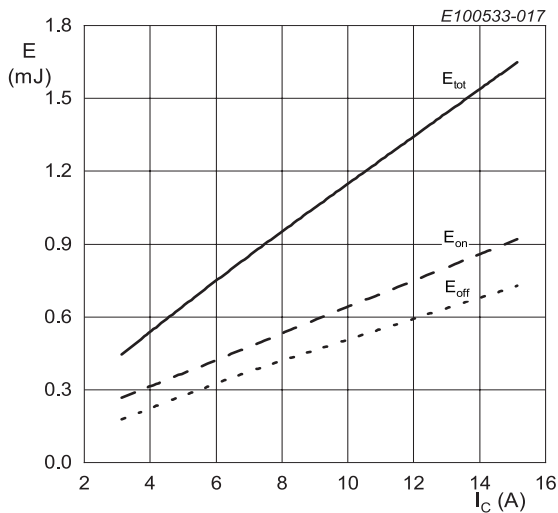
$I_C = 15$ A; $V_{GE} = 15$ V/0 V; $T_J = 175$ °C;
 $V_{CE} = 600$ V; inductive load

Fig. 15. Typical switching times as a function of gate resistance



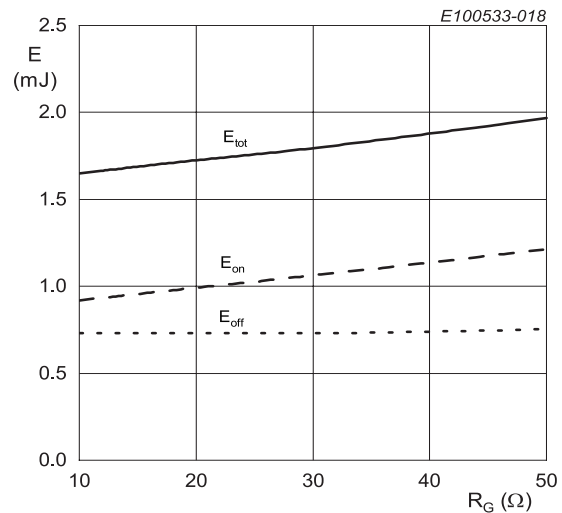
$I_C = 15$ A; $V_{GE} = 15$ V/0 V; $R_g = 10$ Ω ;
 $V_{CE} = 600$ V; inductive load

Fig. 16. Typical switching times as a function of junction temperature



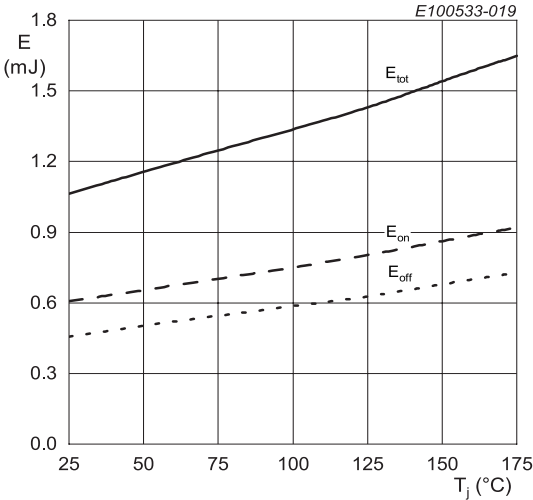
$R_g = 10$ Ω ; $V_{GE} = 15$ V/0 V; $T_J = 175$ °C;
 $V_{CE} = 600$ V; inductive load

Fig. 17. Typical switching energy losses as a function of collector current



$I_C = 15$ A; $V_{GE} = 15$ V/0 V; $T_J = 175$ °C;
 $V_{CE} = 600$ V; inductive load

Fig. 18. Typical switching energy losses as a function of gate resistance



I_C = 15 A; V_{GE} = 15V/0V; R_g = 10 Ω;
V_{CE} = 600 V; inductive load

Fig. 19. Typical switching energy losses as a function of junction temperature

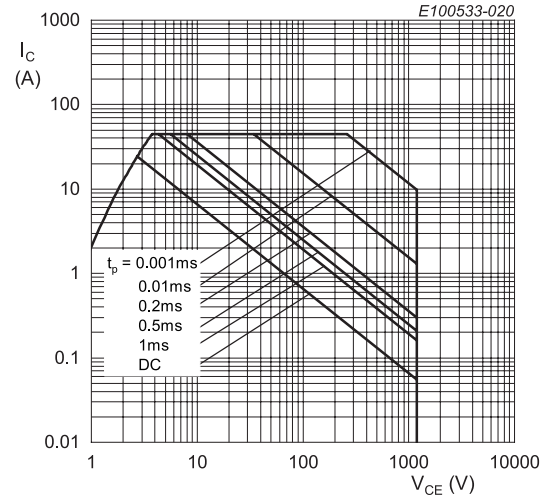


Fig. 20. Forward bias safe operating area

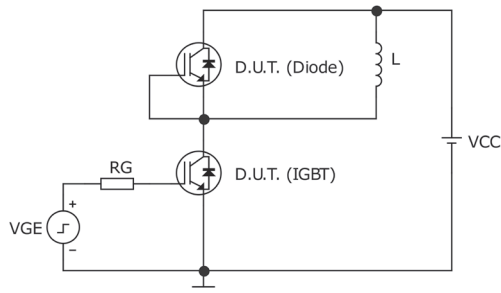


Fig. 21. Test circuit for inductive load switching

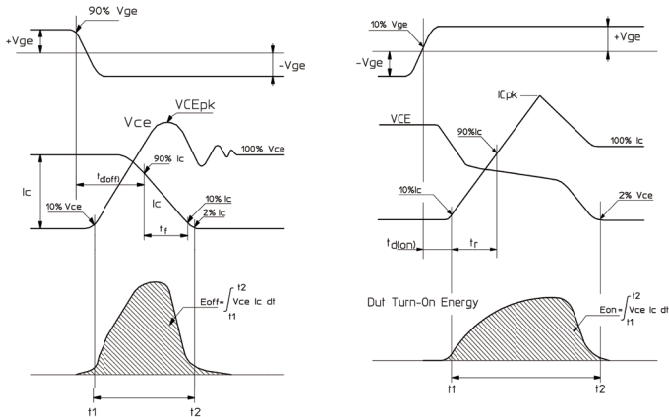
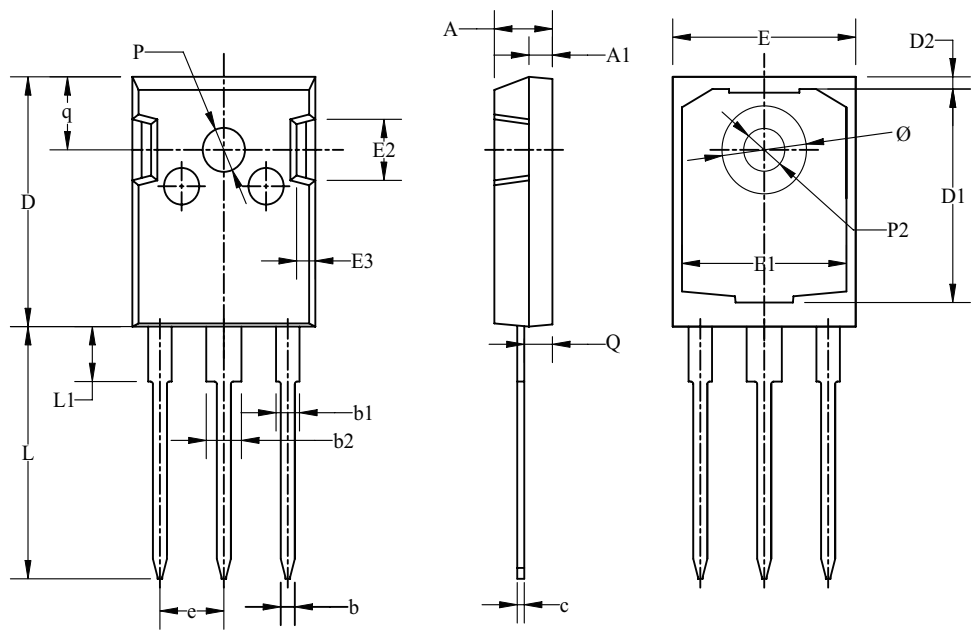


Fig. 22. Definition of switching times and losses

12. Package outline

Plastic single-ended through-hole package; headsink mounted; 1 mounting hole; 3 leads TO-247

TO247



Dim	All Dimensions in Millimeters		
	Min	Typ	Max
A	4.70	4.95	5.20
A1	1.90	2.00	2.10
b	1.00	1.20	1.40
b1	1.80	2.00	2.20
b2	2.80	3.00	3.20
c	0.50	0.60	0.70
D	20.30	20.45	20.60
D1	17.28	17.48	17.68
D2	0.80	1.00	1.20
E	15.45	15.60	15.75
E1	13.82	14.02	14.22
E2	4.80	5.00	5.20
E3	1.40	1.60	1.80
e	5.45 BSC		
L	20.40	20.65	20.90
L1	4.25	4.50	4.75
P2	3.40	3.50	3.60
P	3.50	3.60	3.70
Q	2.20	2.40	2.60
q	5.78	5.98	6.18
Ø	7.10	7.19	7.30

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.ween-semi.com>.

Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. WeEn Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local WeEn Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between WeEn Semiconductors and its customer, unless WeEn Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the WeEn Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, WeEn Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. WeEn Semiconductors takes no responsibility for the content in this document if provided by an information source outside of WeEn Semiconductors.

In no event shall WeEn Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, WeEn Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of WeEn Semiconductors.

Right to make changes — WeEn Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — WeEn Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an WeEn Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. WeEn Semiconductors and its suppliers accept no liability for inclusion and/or use of WeEn Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. WeEn Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using WeEn Semiconductors products, and WeEn Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the WeEn Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

WeEn Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using WeEn Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). WeEn does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific WeEn Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. WeEn Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without WeEn Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond WeEn Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies WeEn Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond WeEn Semiconductors' standard warranty and WeEn Semiconductors' product specifications.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

14. Contents

1. General description..... 1

2. Features and benefits 1

3. Applications 1

4. Quick reference data..... 1

5. Pinning information..... 2

6. Ordering information..... 2

7. Marking..... 2

8. Limiting values 3

9. Thermal characteristics 4

10. Characteristics..... 5

11. Switching Characteristics..... 6

12. Package outline 12

13. Legal information 13

14. Contents 14

© WeEn Semiconductors Co., Ltd. 2025. All rights reserved

For more information, please visit: <http://www.ween-semi.com>

For sales office addresses, please send an email to: salesaddresses@ween-semi.com

Date of release: 14 October 2025